



PATENT APPLICATION

IFW

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Iori YOSHIKAWA

Group Art Unit: 2877

Application No.: 10/589,336

Filed: August 14, 2006

Docket No.: 127630

For: MEASUREMENT METHOD, TRANSFER CHARACTERISTIC MEASUREMENT METHOD, ADJUSTMENT METHOD OF EXPOSURE APPARATUS, AND DEVICE MANUFACTURING METHOD

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to Reference 1 of the PTO Form 1449 filed concurrently with the Information Disclosure Statement on October 17, 2006. It is respectfully requested that this be corrected to include the English-language translation with the English-language abstract, which provides further concise explanation of potential relevance of the reference cited therein.

This Information Disclosure Statement is being before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.

Respectfully submitted,

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MAC:SPC/ejw

Date: November 22, 2006

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DEPOSIT ACCOUNT USE AUTHORIZATION Please grant any extension necessary for entry; Charge any fee due to our Deposit Account No. 15-0461
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Sheet 1 of 1Form PTO-1449  
(REV. 1/06)US Dept. of Commerce  
PATENT & TRADEMARK OFFICEATTY DOCKET NO.  
127630APPLICATION NO.  
10/589,336

## INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANT(S)  
Iori YOSHIKAWAFILING DATE  
August 14, 2006GROUP  
2877

## U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Name

## FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
	1	JP A 04-132909	05/07/1992	JAPAN	X	X

## OTHER DOCUMENTS

Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER

/Jon Chang/

DATE CONSIDERED

03/23/2010

Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Date: November 22, 2006

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /J.C./